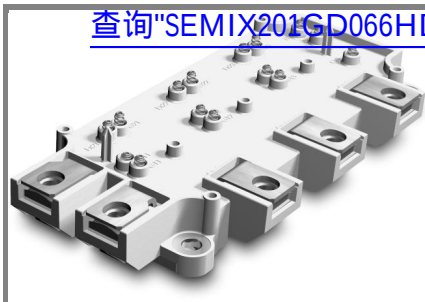


查询"SEMiX201GD066HDs"供应商



SEMiX® 13s

Trench IGBT Modules

SEMiX 201GD066HDs

Preliminary Data

Features

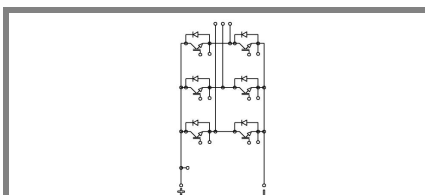
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient

Typical Applications

- Matrix Converter
- Resonant Inverter
- Current Source Inverter

Remarks

- Case temperatur limited to $T_C=125^{\circ}\text{C}$ max.
- Product reliability results are valid for $T_j=150^{\circ}\text{C}$
- SC data: $t_p \leq 6 \mu\text{s}$; $V_{GE} \leq 15 \text{ V}$; $T_j = 150^{\circ}\text{C}$; $V_{CC} = 360 \text{ V}$, use of soft R_G necessary
- take care of over-voltage caused by stray inductance

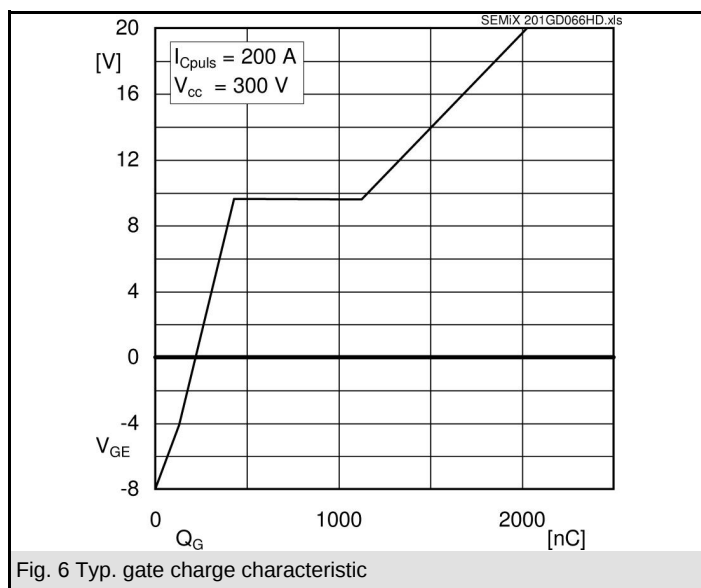
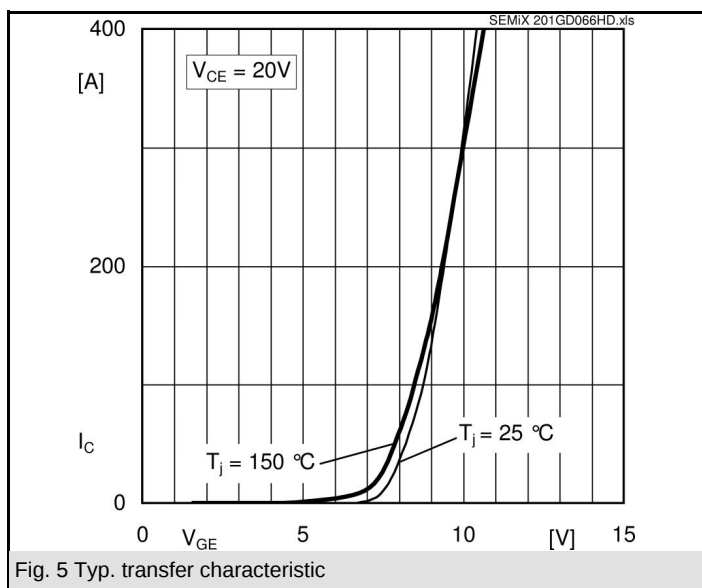
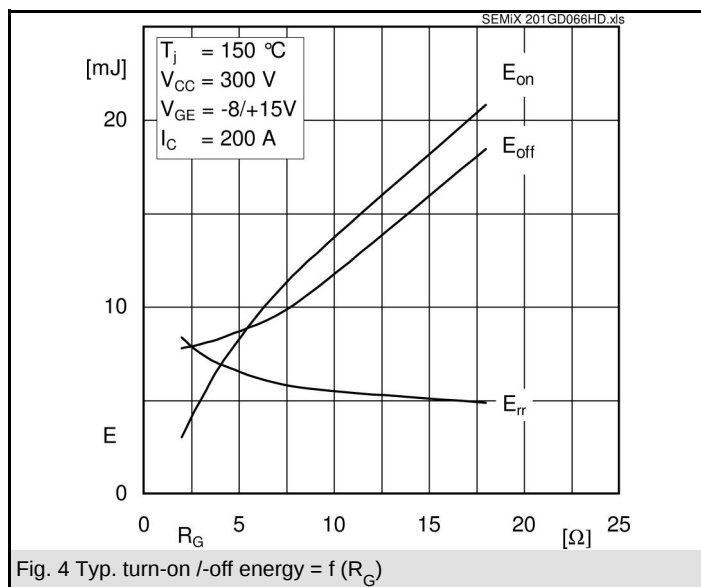
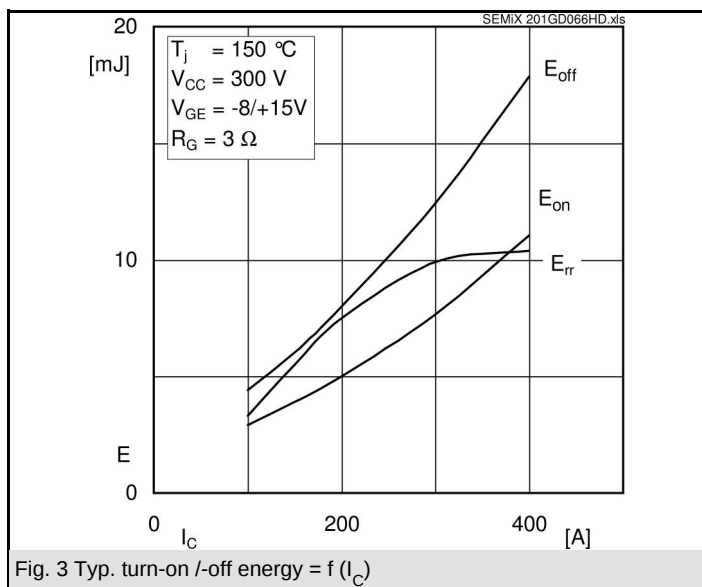
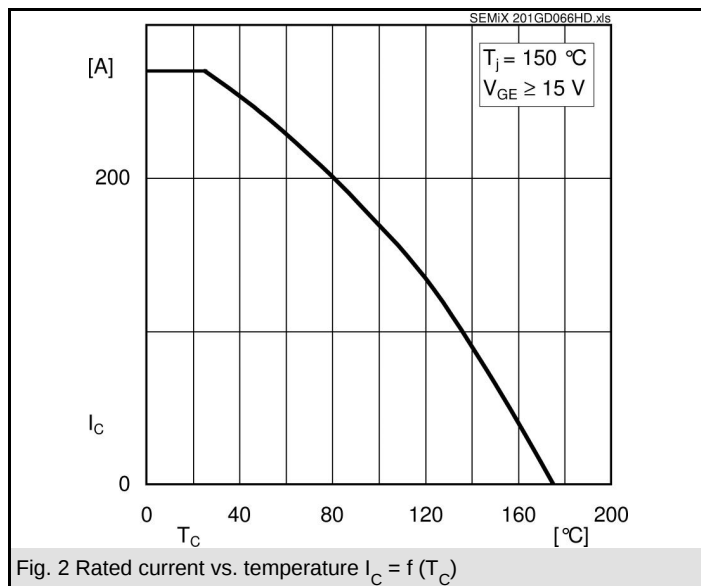
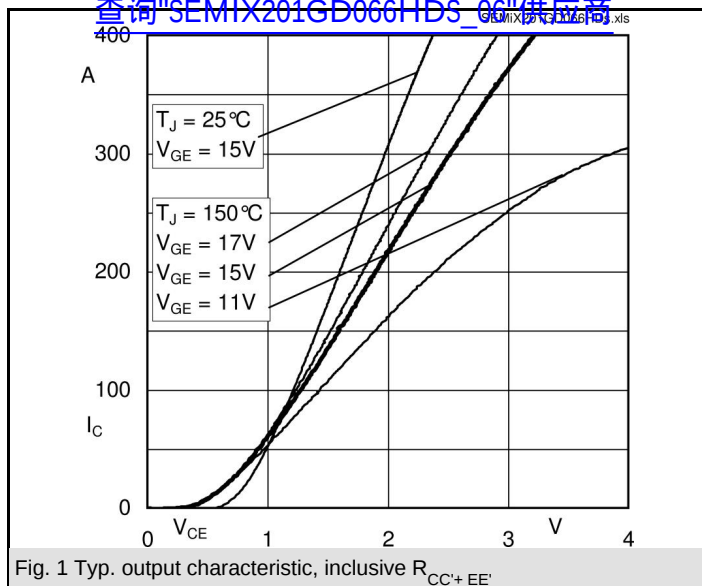


GD

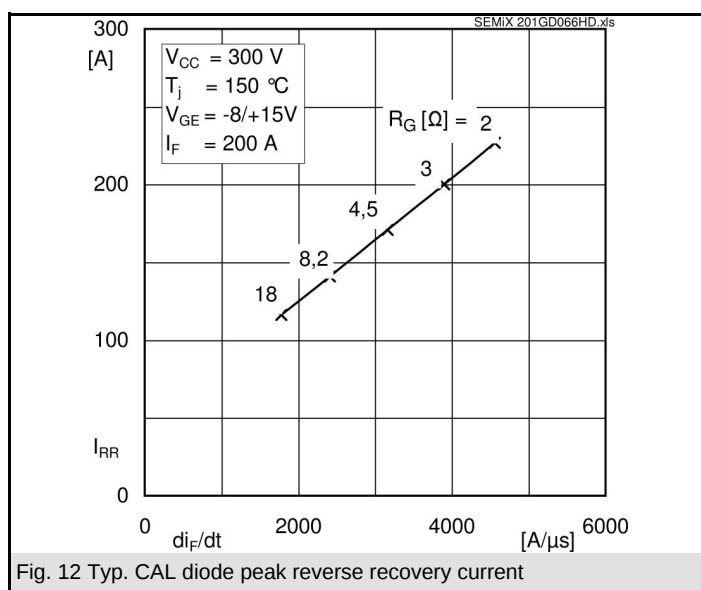
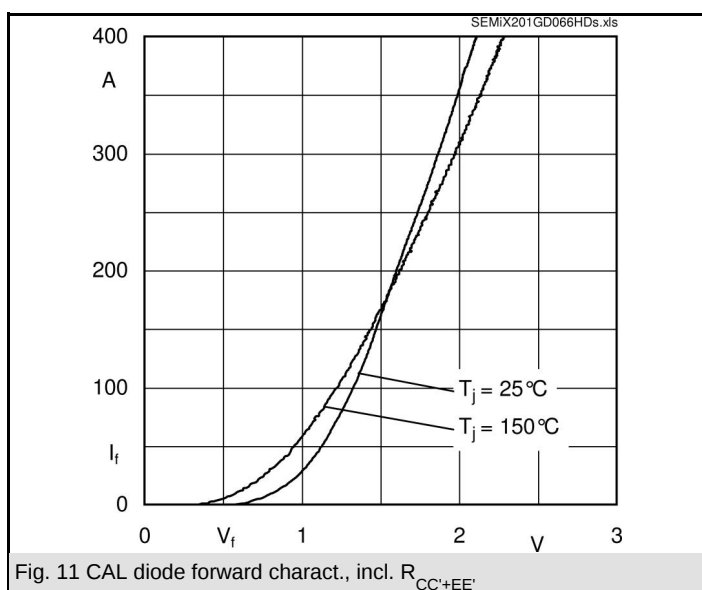
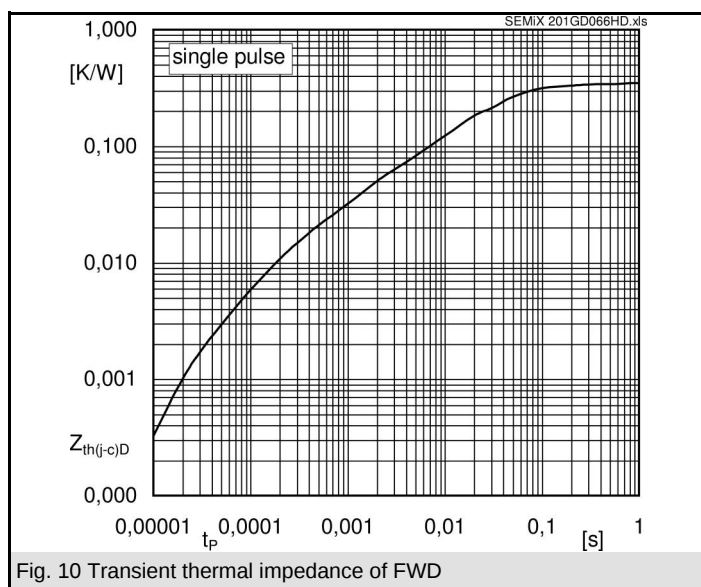
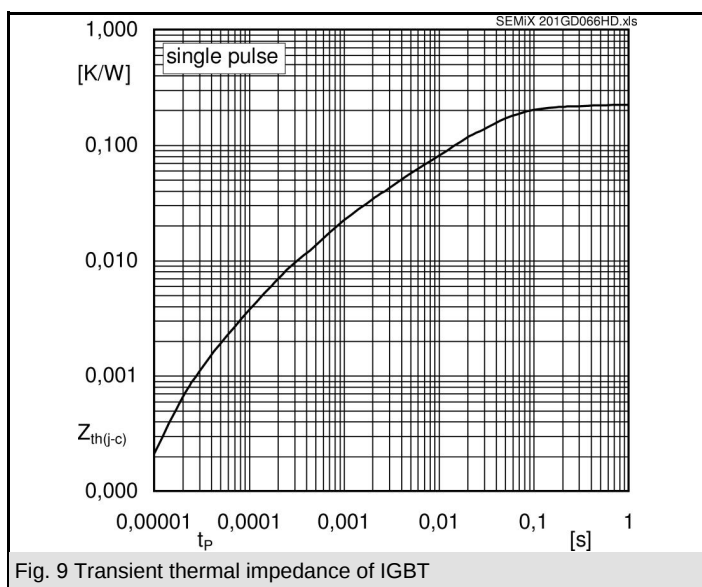
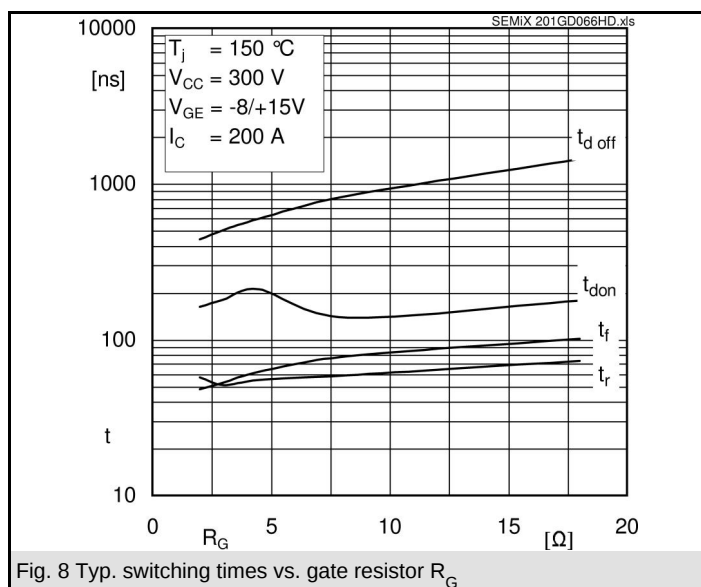
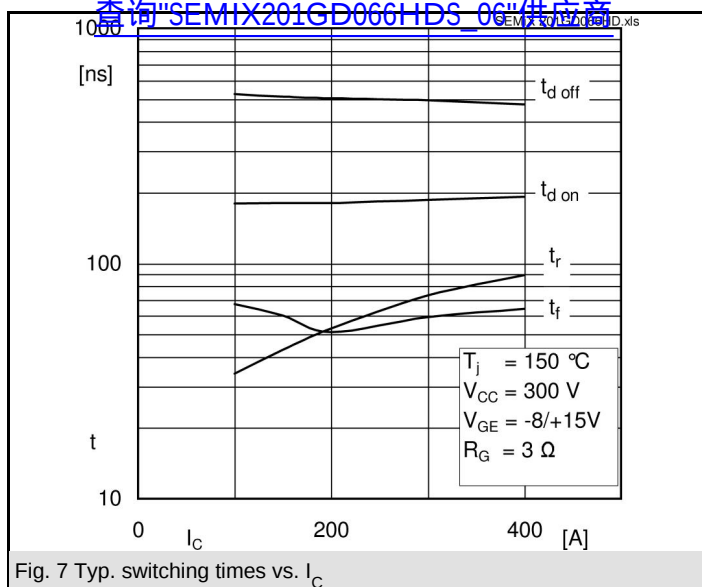
Absolute Maximum Ratings		$T_{case} = 25^{\circ}\text{C}$, unless otherwise specified	
Symbol	Conditions	Values	Units
IGBT			
V_{CES}		600	V
I_C	$T_C = 25 (80)^{\circ}\text{C}$, $T_j = 150^{\circ}\text{C}$	240 (170)	A
I_C	$T_C = 25 (80)^{\circ}\text{C}$, $T_j = 175^{\circ}\text{C}$	270 (200)	A
I_{CRM}	$t_p = 1 \text{ ms}$	400	A
V_{GES}		± 20	V
$T_j, (T_{stg})$		$-40 \dots +175 (125)$	$^{\circ}\text{C}$
V_{isol}	AC, 1 min.	4000	V
Inverse diode			
I_F	$T_C = 25 (80)^{\circ}\text{C}$, $T_j = 150^{\circ}\text{C}$	190 (130)	A
I_F	$T_C = 25 (80)^{\circ}\text{C}$, $T_j = 175^{\circ}\text{C}$	210 (160)	A
I_{FRM}	$t_p = 1 \text{ ms}$	400	A
I_{FSM}	$t_p = 10 \text{ ms}$; sin.; $T_j = 25^{\circ}\text{C}$	1300	A

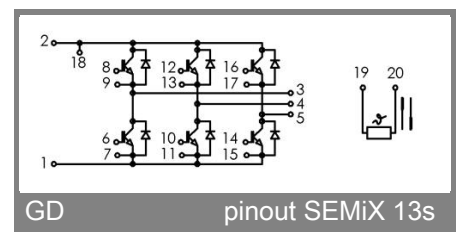
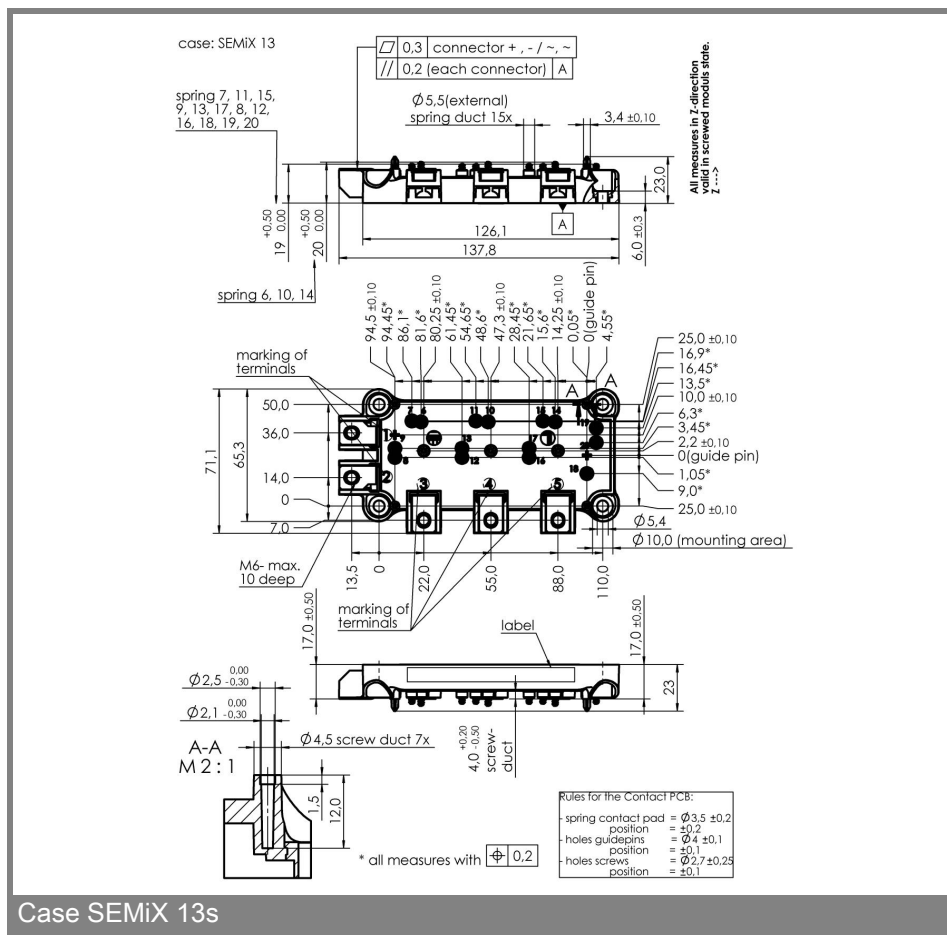
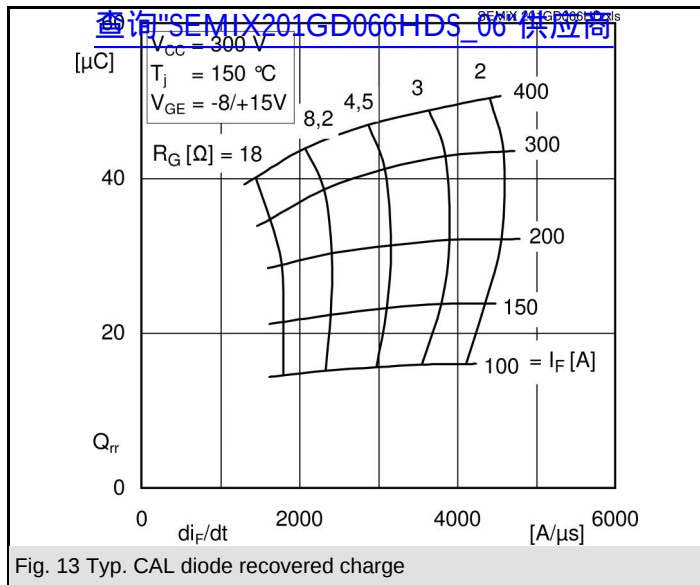
Characteristics		$T_{case} = 25^{\circ}\text{C}$, unless otherwise specified		
Symbol	Conditions	min.	typ.	max. Units
IGBT				
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 6,4 \text{ mA}$		5,8	V
I_{CES}	$V_{GE} = 0$, $V_{CE} = V_{CES}$, $T_j = 25 (^{\circ})^{\circ}\text{C}$			mA
$V_{CE(TO)}$	$T_j = 25 (150)^{\circ}\text{C}$		0,9 (0,85)	1 (0,9) V
r_{CE}	$V_{GE} = 15 \text{ V}$, $T_j = 25 (150)^{\circ}\text{C}$		2,8 (4,3)	4,5 (6) $\text{m}\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 200 \text{ A}$, $V_{GE} = 15 \text{ V}$, $T_j = 25 (150)^{\circ}\text{C}$, chip level		1,45 (1,7)	1,9 (2,1) V
C_{ies}	under following conditions		12,3	nF
C_{oes}	$V_{GE} = 0$, $V_{CE} = 25 \text{ V}$, $f = 1 \text{ MHz}$		0,77	nF
C_{res}			0,37	nF
L_{CE}			20	nH
$R_{CC+EE'}$	terminal-chip, $T_C = 25 (125)^{\circ}\text{C}$		0,7 (1)	$\text{m}\Omega$
$t_{d(on)}/t_r$	$V_{CC} = 300 \text{ V}$, $I_{Cnom} = 200 \text{ A}$		180 / 55	ns
$t_{d(off)}/t_f$	$V_{GE} = -8/+15 \text{ V}$		500 / 55	ns
$E_{on} (E_{off})$	$R_{Gon} = R_{Goff} = 3 \Omega$, $T_j = 150^{\circ}\text{C}$		5 (8)	mJ
Inverse diode				
$V_F = V_{EC}$	$I_{Fnom} = 200 \text{ A}$; $V_{GE} = 0 \text{ V}$; $T_j = 25 (150)^{\circ}\text{C}$, chip level		1,4 (1,4)	1,6 V
$V_{(TO)}$	$T_j = 25 (150)^{\circ}\text{C}$		1 (0,85)	1,1 V
r_T	$T_j = 25 (150)^{\circ}\text{C}$		2 (2,8)	2,5 $\text{m}\Omega$
I_{RRM}	$I_{Fnom} = 200 \text{ A}$; $T_j = 25 (150)^{\circ}\text{C}$		200	A
Q_{rr}	$di/dt = 3900 \text{ A}/\mu\text{s}$		32	μC
E_{rr}	$V_{GE} = -8 \text{ V}$		7,5	mJ
Thermal characteristics				
$R_{th(j-c)}$	per IGBT		0,22	K/W
$R_{th(j-c)D}$	per Inverse Diode		0,38	K/W
$R_{th(j-c)FD}$	per FWD			K/W
$R_{th(c-s)}$	per module		0,04	K/W
Temperature sensor				
R_{25}	$T_C = 25^{\circ}\text{C}$		$5 \pm 5\%$	k Ω
$B_{25/85}$	$R_2 = R_1 \exp[B(1/T_2 - 1/T_1)]$; $T[K]$; B		3420	K
Mechanical data				
M_s/M_t	to heatsink (M5) / for terminals (M6)	3/2,5	5 / 5	Nm
w		290		g

查询"SEMiX201GD066HDS_06"供应商



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.